

**32M-Bit (4Mx8 /2Mx16) CMOS MASK ROM****FEATURES**

- Switchable organization  
4,194,304x8(byte mode)  
2,097,152x16(word mode)
- Fast access time  
3.3V Operation : 120ns(Max.)  
3.0V Operation : 150ns(Max.)
- Supply voltage : single +3.0V/ single +3.3V
- Current consumption  
Operating : 40mA(Max.)  
Standby : 30μA(Max.)
- Fully static operation
- All inputs and outputs TTL compatible
- Three state outputs
- Package
  - K3N6V(U)1000C-GC : 44-SOP-600

**GENERAL DESCRIPTION**

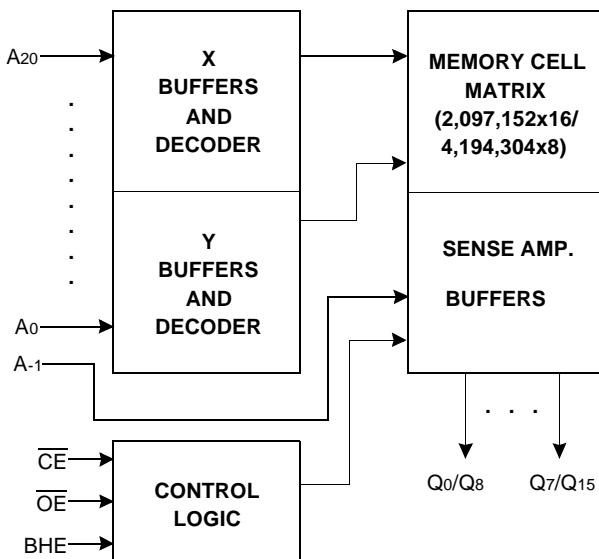
The K3N6V(U)1000C-GC is a fully static mask programmable ROM fabricated using silicon gate CMOS process technology, and is organized either as 4,194,304 x 8 bit(byte mode) or as 2,097,152 x 16 bit(word mode) depending on BHE voltage level.(See mode selection table)

This device operates with 3.0V or 3.3V power supply, and all inputs and outputs are TTL compatible.

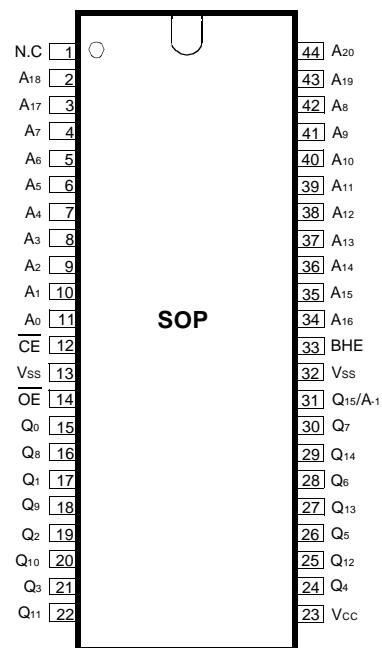
Because of its asynchronous operation, it requires no external clock assuring extremely easy operation.

It is suitable for use in program memory of microprocessor, and data memory, character generator.

The K3N6V(U)1000C-GC is packaged in a 44-SOP.

**FUNCTIONAL BLOCK DIAGRAM**

Pin Name	Pin Function
A <sub>0</sub> - A <sub>20</sub>	Address Inputs
Q <sub>0</sub> - Q <sub>14</sub>	Data Outputs
Q <sub>15</sub> /A <sub>-1</sub>	Output 15(Word mode)/ LSB Address(Byte mode)
BHE	Word/Byte selection
CE	Chip Enable
OE	Output Enable
Vcc	Power
Vss	Ground
N.C	No Connection

**PIN CONFIGURATION**

K3N6V(U)1000C-GC



**ABSOLUTE MAXIMUM RATINGS**

Item	Symbol	Rating	Unit
Voltage on Any Pin Relative to Vss	VIN	-0.3 to +4.5	V
Temperature Under Bias	TBIAS	-10 to +85	°C
Storage Temperature	Tstg	-55 to +150	°C

**NOTE :** Permanent device damage may occur if "ABSOLUTE MAXIMUM RATINGS" are exceeded. Functional operation should be restricted to the conditions as detailed in the operational sections of this data sheet. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

**RECOMMENDED OPERATING CONDITIONS**(Voltage reference to Vss, TA=0 to 70°C)

Item	Symbol	Min	Typ	Max	Unit
Supply Voltage	Vcc	2.7/3.0	3.0/3.3	3.3/3.6	V
Supply Voltage	Vss	0	0	0	V

**DC CHARACTERISTICS**

Parameter	Symbol	Test Conditions		Min	Max	Unit
Operating Current	Icc	$\overline{CE}=\overline{OE}=VIL$ , all outputs open	Vcc=3.3V±0.3V	-	40	mA
			Vcc=3.0V±0.3V		35	mA
Standby Current(TTL)	Isb1	$\overline{CE}=Vih$ , all outputs open			500	µA
Standby Current(CMOS)	Isb2	$\overline{CE}=Vcc$ , all outputs open			30	µA
Input Leakage Current	ILI	VIN=0 to Vcc		-	10	µA
Output Leakage Current	ILO	VOUT=0 to Vcc		-	10	µA
Input High Voltage, All Inputs	VIH			2.0	Vcc+0.3	V
Input Low Voltage, All Inputs	VIL			-0.3	0.6	V
Output High Voltage Level	VOH	IOH=-400µA		2.4	-	V
Output Low Voltage Level	VOL	IOL=2.1mA		-	0.4	V

**NOTE :** Minimum DC Voltage(VIL) is -0.3V at input pins. During transitions, this level may undershoot to -2.0V for periods <20ns.

Maximum DC voltage on input pins(VIH) is Vcc+0.3V which, during transitions, may overshoot to Vcc+2.0V for periods <20ns.

**MODE SELECTION**

CE	OE	BHE	Q15/A-1	Mode	Data	Power
H	X	X	X	Standby	High-Z	Standby
L	H	X	X	Operating	High-Z	Active
L	L	H	Output	Operating	Q0~Q15 : Dout Q0~Q7 : Dout Q8~Q14 : Hi-Z	Active
		L	Input	Operating	Q0~Q7 : Dout Q8~Q14 : Hi-Z	Active

**CAPACITANCE**(TA=25°C, f=1.0MHz)

Item	Symbol	Test Conditions	Min	Max	Unit
Output Capacitance	COUT	VOUT=0V	-	12	pF
Input Capacitance	CIN	VIN=0V	-	12	pF

**NOTE :** Capacitance is periodically sampled and not 100% tested.



## AC CHARACTERISTICS (TA=0°C to +70°C, Vcc=3.3V/3.0V±0.3V, unless otherwise noted.)

## TEST CONDITIONS

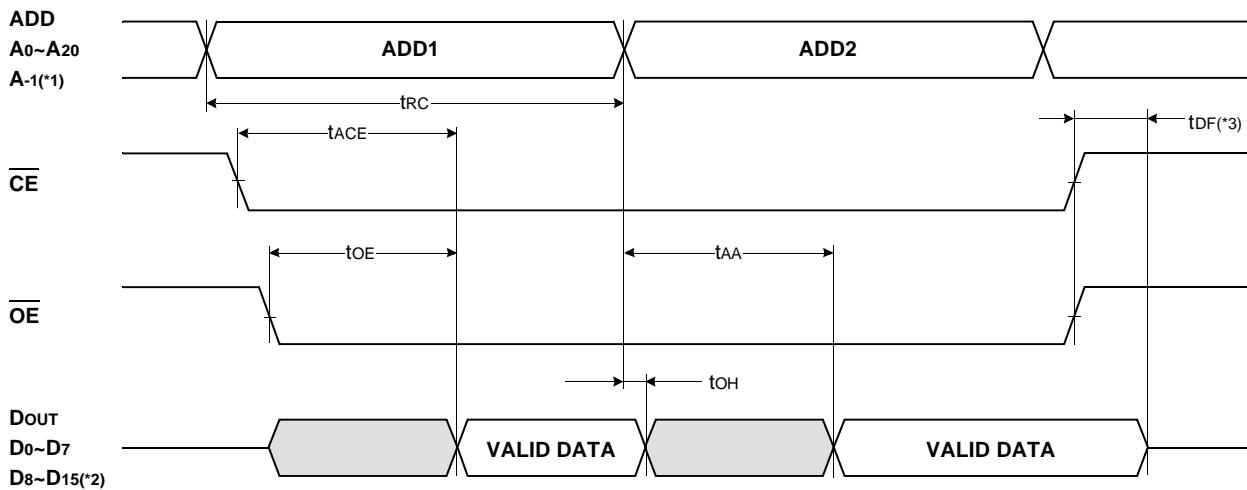
Item	Value
Input Pulse Levels	0.45V to 2.4V
Input Rise and Fall Times	10ns
Input and Output timing Levels	1.5V
Output Loads	1 TTL Gate and CL=100pF

## READ CYCLE

Item	Symbol	Vcc=3.3V±0.3V		Vcc=3.0V±0.3V		Unit
		Min	Max	Min	Max	
Read Cycle Time	tRC	120		150		ns
Chip Enable Access Time	tACE		120		150	ns
Address Access Time	tAA		120		150	ns
Output Enable Access Time	toE		60		70	ns
Output or Chip Disable to Output High-Z	tDF		20		30	ns
Output Hold from Address Change	toH	0		0		ns

## TIMING DIAGRAM

## READ



## NOTES :

\*1. Byte Mode only. A-1 is Least Significant Bit Address.(BHE = VIL)

\*2. Word Mode only.(BHE = VIH)

\*3. tDF is defined as the time at which the outputs achieve the open circuit condition and is not referenced to VOH or VOL level.



ELECTRONICS

## PACKAGE DIMENSIONS

(Unit : mm/inch)

